

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/786,472 ICHIHARA ET AL.	
		Examiner	Art Unit	Page 1 of 1 Rodney H. Bonck 3681

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0085091 A1	05-2003	Ichihara et al.	192/45
*	B	US-2003/0000792 A1	01-2003	Fujiwara, Hideki	192/45
C	US-				
D	US-				
E	US-				
F	US-				
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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